


<b>Search Notes</b> 	<b>Application/Control No.</b>		<b>Applicant(s)/Patent under Reexamination</b>	
	10/678,714		MIHAI ET AL.	
	<b>Examiner</b>		<b>Art Unit</b>	
	Emeka Ebirim		2166	

SEARCHED			
Class	Subclass	Date	Examiner
707	1-10	3/8/2006	EE

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	3/8/2006	EE
NPL (Google, ACM)	3/8/2006	EE
Consulted Pham Khanh (primary)	3/9/2006	EE
Consulted Alam Hosain (SPE)	3/9/2006	EE